

December 19, 2017

## DASY/EASY - Parameters of Probe: ER3DV6 - SN:2272

#### **Basic Calibration Parameters**

20 00 00	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	1.60	1.67	1.72	± 10.1 %
DCP (mV) <sup>B</sup>	101.0	97.8	100.7	

**Modulation Calibration Parameters** 

UID	Communication System Name		A dB	B dB√μV	С	D dB	VR mV	Unc <sup>E</sup> (k=2)
0	CW	X	0.0	0.0	1.0	0.00	200.2	±3.5 %
		Y	0.0	0.0	1.0		165.8	
		Z	0.0	0.0	1.0		197.0	

Note: For details on UID parameters see Appendix.

**Sensor Model Parameters** 

	C1 fF	C2 fF	α V <sup>-1</sup>	T1 ms.V <sup>-2</sup>	T2 ms.V <sup>-1</sup>	T3 ms	T4 V <sup>-2</sup>	T5 V <sup>-1</sup>	Т6
X	94.34	448.4	35.94	25.97	1.333	5.10	0.00	0.662	1.014
Υ	100.1	483.8	36.93	26.47	1.401	5.10	0.00	0.669	1.019
Z	83.01	396.9	36.42	29.84	3.892	5.10	0.00	0.874	1.016

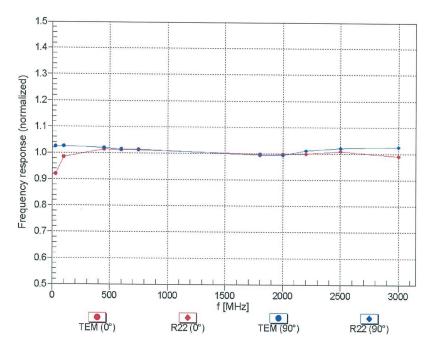
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

B Numerical linearization parameter: uncertainty not required.
E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



December 19, 2017

# Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



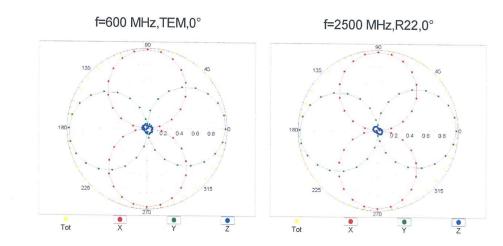
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Certificate No: ER3-2272\_Dec17

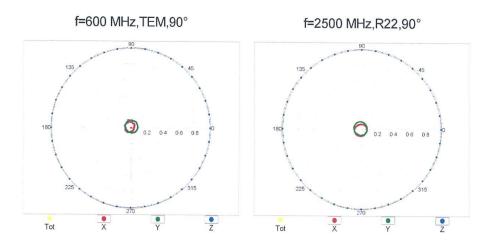


ER3DV6 – SN:2272 December 19, 2017

## Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$



## Receiving Pattern ( $\phi$ ), $\vartheta = 90^{\circ}$

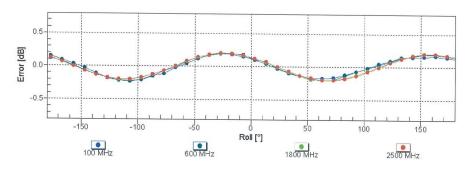


Certificate No: ER3-2272\_Dec17 Page 6 of 38



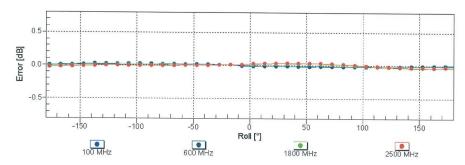
December 19, 2017

## Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

## Receiving Pattern ( $\phi$ ), $\vartheta = 90^{\circ}$



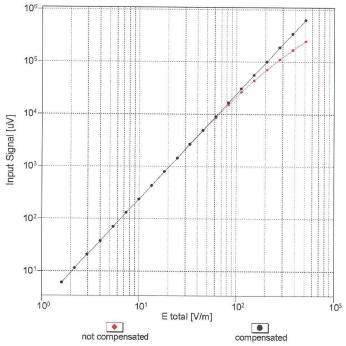
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

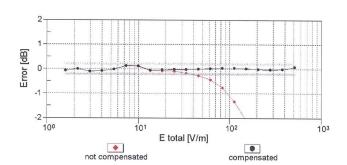


ER3DV6 - SN:2272 December 19, 2017

## Dynamic Range f(E-field) (TEM cell , f = 900 MHz)

,





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

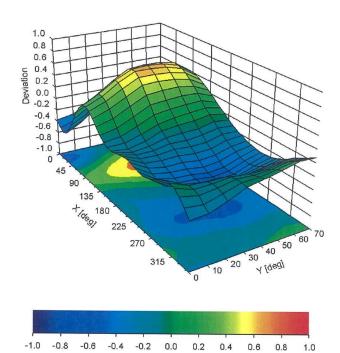
Certificate No: ER3-2272\_Dec17 Page 8 of 38



ER3DV6 – SN:2272 December 19, 2017

## **Deviation from Isotropy in Air**

Error  $(\phi, \vartheta)$ , f = 900 MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm$  2.6% (k=2)

Certificate No: ER3-2272\_Dec17 Page 9 of 38



December 19, 2017

## DASY/EASY - Parameters of Probe: ER3DV6 - SN:2272

#### **Other Probe Parameters**

Sensor Arrangement	Rectangular
Connector Angle (°)	112.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2272\_Dec17



#### ANNEX E DIPOLE CALIBRATION CERTIFICATE

#### Dipole 835 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

CTTL (Auden)

Certificate No: CD835V3-1023 Aug17

Object	CD835V3 - SN:	1023	
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	dure for dipoles in air	
Calibration date:	August 23, 2017		
The measurements and the unce	rtainties with confidence p	onal standards, which realize the physical unit robability are given on the following pages and ry facility: environment temperature $(22\pm3)^{\circ}$ C	d are part of the certificate.
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	04-Apr-17 (No. 217-02521/02522)	Apr-18
Power sensor NRP-Z91	SN: 103244	04-Apr-17 (No. 217-02521)	Apr-18
Power sensor NRP-Z91	SN: 103245	04-Apr-17 (No. 217-02522)	Apr-18
Reference 20 dB Attenuator	SN: 5058 (20k)	07-Apr-17 (No. 217-02528)	Apr-18
Type-N mismatch combination	SN: 5047.2 / 06327	07-Apr-17 (No. 217-02529)	Apr-18
	SN: 2336	30-Dec-16 (No. ER3-2336_Dec16)	Dec-17
Probe ER3DV6	100-00-000-00-00-00-00-00-00-00-00-00-00	30-Dec-16 (No. H3-6065_Dec16)	Dec-17
	SN: 6065	50-Dec-10 (No. 115-0005_Dec10)	
Probe H3DV6	SN: 6065 SN: 781	13-Jul-17 (No. DAE4-781_Jul17)	Jul-18
Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	SN: 781	and the second side of the secon	
Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B	SN: 781 ID # SN: GB42420191	13-Jul-17 (No. DAE4-781_Jul17)  Check Date (in house)  09-Oct-09 (in house check Sep-14)	Jul-18  Scheduled Check In house check: Oct-17
Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A	SN: 781 ID # SN: GB42420191 SN: US38485102	13-Jul-17 (No. DAE4-781_Jul17)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)	Jul-18  Scheduled Check  In house check: Oct-17 In house check: Oct-17
Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597	13-Jul-17 (No. DAE4-781_Jul17)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)	Jul-18  Scheduled Check  In house check: Oct-17 In house check: Oct-17 In house check: Oct-17
Probe H3DV6 DAE4  Secondary Standards  Power meter Agilent 4419B  Power sensor HP E4412A  Power sensor HP 8482A  RF generator R&S SMT-06	SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011	13-Jul-17 (No. DAE4-781_Jul17)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)  27-Aug-12 (in house check Oct-15)	Jul-18  Scheduled Check In house check: Oct-17 In house check: Oct-17 In house check: Oct-17 In house check: Oct-17
Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06	SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597	13-Jul-17 (No. DAE4-781_Jul17)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)	Jul-18  Scheduled Check In house check: Oct-17
Probe H3DV6 DAE4  Secondary Standards Power meter Agillent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06 Network Analyzer HP 8753E	SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585 Name	13-Jul-17 (No. DAE4-781_Jul17)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)  27-Aug-12 (in house check Oct-15)  18-Oct-01 (in house check Oct-16)  Function	Jul-18  Scheduled Check In house check: Oct-17 In house check: Oct-17 In house check: Oct-17 In house check: Oct-17
Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	SN: 781  ID #  SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585	13-Jul-17 (No. DAE4-781_Jul17)  Check Date (in house)  09-Oct-09 (in house check Sep-14)  05-Jan-10 (in house check Sep-14)  09-Oct-09 (in house check Sep-14)  27-Aug-12 (in house check Oct-15)  18-Oct-01 (in house check Oct-16)	Jul-18  Scheduled Check In house check: Oct-17 In house check: Oct-17 In house check: Oct-17 In house check: Oct-17

Certificate No: CD835V3-1023\_Aug17

Page 1 of 8



### No.I17Z62005-SEM02 Page 44 of 64

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

#### References

- [1] ANSI-C63.19-2007
  American National Standard for Methods of Measurement of Compatibility between Wireless Communications
  Devices and Hearing Aids.
- [2] ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

#### Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
  figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
  is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
  directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
  antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
  maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
  calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
  feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD835V3-1023\_Aug17 Page 2 of 8



#### **Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.0
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10, 15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

#### Maximum Field values at 835 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.457 A/m ± 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	168.6 V/m = 44.54 dBV/m
Maximum measured above low end	100 mW input power	165.9 V/m = 44.40 dBV/m
Averaged maximum above arm	100 mW input power	167.3 V/m ± 12.8 % (k=2)

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	108.0 V/m = 40.67 dBV/m
Maximum measured above low end	100 mW input power	107.9 V/m = 40.66 dBV/m
Averaged maximum above arm	100 mW input power	108.0 V/m ± 12.8 % (k=2)



### Appendix (Additional assessments outside the scope of SCS 0108)

#### **Antenna Parameters**

Frequency	Return Loss	Impedance
800 MHz	16.8 dB	41.0 Ω - 9.7 jΩ
835 MHz	23.2 dB	53.2 Ω + 6.4 jΩ
900 MHz	15.7 dB	52.8 Ω - 16.9 jΩ
950 MHz	23.1 dB	$48.9 \Omega + 6.9 j\Omega$
960 MHz	16.9 dB	58.6 Ω + 13.1 jΩ

#### 3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

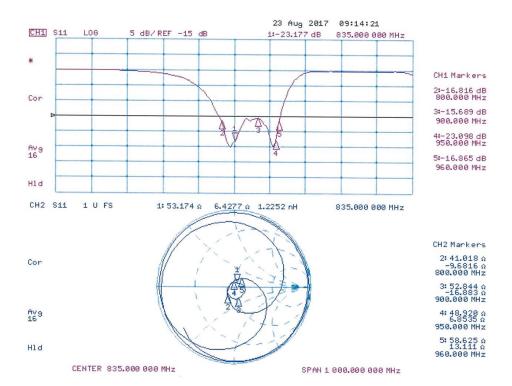
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



#### **Impedance Measurement Plot**





#### **DASY5 H-field Result**

Test Laboratory: SPEAG Lab2

Date: 22.08.2017

#### DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used:  $\sigma=0$  S/m,  $\epsilon_r=1$ ;  $\rho=1$  kg/m³ Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 30.12.2016
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 13.07.2017
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

## Dipole~H-Field~measurement~@~835MHz/H-Scan-835MHz~d=10mm/Hearing~Aid~Compatibility~Test

(41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.4830 A/m; Power Drift = 0.04 dB

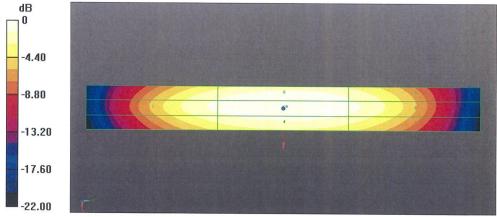
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.4568 A/m

Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

Grid 1 <b>M4</b> <b>0.368 A/m</b>		
Grid 4 <b>M4</b> <b>0.416 A/m</b>	INVESTIGATION OF THE COURSE	
Grid 7 <b>M4</b> <b>0.373 A/m</b>		



0 dB = 0.4568 A/m = -6.81 dBA/m

Certificate No: CD835V3-1023\_Aug17



#### **DASY5 E-field Result**

Date: 22.08.2017

Test Laboratory: SPEAG Lab2

#### DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2016;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 13.07.2017
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

### Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test

(41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 108.5 V/m; Power Drift = -0.03 dB

Applied MIF = 0.00 dB

RF audio interference level = 44.54 dBV/m

Emission category: M3

#### MIF scaled E-field

Grid 1 M3 44.17 dBV/m	Grid 3 M3 44.08 dBV/m
Grid 4 M4 38.83 dBV/m	Grid 6 M4 38.86 dBV/m
Grid 7 M3 44.02 dBV/m	Grid 9 M3 44.45 dBV/m

Certificate No: CD835V3-1023\_Aug17



Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test

(41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 108.0 V/m; Power Drift = 0.01 dB

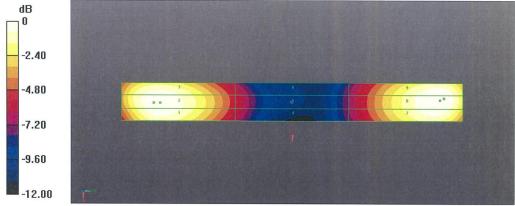
Applied MIF = 0.00 dB

RF audio interference level = 40.67 dBV/m

Emission category: M3

MIF scaled E-field

Grid 1 M3 40.52 dBV/m	 Grid 3 M3 40.47 dBV/m
Grid 4 M4 36.06 dBV/m	Grid 6 M4 36.03 dBV/m
Grid 7 M3 40.48 dBV/m	Grid 9 <b>M3</b> <b>40.6 dBV/m</b>



0 dB = 168.6 V/m = 44.54 dBV/m